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Application/Control No.	Applicant(s)/Patent under Reexamination	,
10/780,547	CRIDER ET AL.	
Examiner	Art Unit	
Maikhanh Nguyen	2176	

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715	513 517	9/30/2007	MK
715	523 526	9/30/2007	MK
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Inventor Name Search	9/28/2007	МК
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History Printout	9/30/2007	МК